

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/796,270	WANG ET AL.
	Examiner	Art Unit
	Hien N. Nguyen	2824

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
365	201	365	189.09 230.06
INTERNATIONAL CLASSIFICATION			
G	1 1 C	7/00	/
		/	/
		/	/
		/	/
HIEN NGUYEN 12/09/05 (Assistant Examiner) (Date) <i>66 12/09/05</i>		RICHARD ELM斯 SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date) <i>66 12/09/05</i>	
		Total Claims Allowed: 21	
		O.G. Print Claim(s) 1	O.G. Print Fig. 17

Claims renumbered in the same order as presented by applicant

Final	Original														
1		31		61		91		121		151		181		152	
2		32		62		92		122		153		182		154	
3		33		63		93		123		155		183		156	
4		34		64		94		124		157		184		158	
5		35		65		95		125		159		185		160	
6		36		66		96		126		161		186		162	
7		37		67		97		127		163		187		164	
8		38		68		98		128		165		188		166	
9		39		69		99		129		167		189		168	
10		40		70		100		130		169		190		170	
11		41		71		101		131		171		191		172	
12		42		72		102		132		173		192		174	
13		43		73		103		133		175		193		176	
14		44		74		104		134		177		194		178	
15		45		75		105		135		179		195		180	
16		46		76		106		136		181		196		182	
17		47		77		107		137		183		197		184	
18		48		78		108		138		185		198		186	
19		49		79		109		139		187		199		188	
20		50		80		110		140		189		200		190	
21		51		81		111		141		191		201		192	
22		52		82		112		142		193		202		194	
23		53		83		113		143		195		203		196	
24		54		84		114		144		197		204		198	
25		55		85		115		145		199		205		200	
26		56		86		116		146		201		206		202	
27		57		87		117		147		203		207		204	
28		58		88		118		148		205		208		206	
29		59		89		119		149		207		209		208	
30		60		90		120		150		209		210		210	